

<b>Search Notes</b>  <b>*1058134</b>  <b>8*</b>	<b>Application/Control No.</b>  10581348	<b>Applicant(s)/Patent Under Reexamination</b>  FUNKE ET AL.
	<b>Examiner</b>  John Pak	<b>Art Unit</b>  1616

SEARCHED			
Class	Subclass	Date	Examiner
514	343, 407	12/2010	JP

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor names searched	12/2010	JP
STN Online, See printout. Files Reg and HCAPLUS searched.	12/2010	JP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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